PTO/SB/08a/b (07-05)
Approved for use through 07/31/2006. OMB 0651-0031
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE
Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/B/PTO				Complete If Known		
				Application Number	10/736,487-Conf. #3809	
IN.	FORMATIC	ON DIS	CLOSURE	Filing Date	December 15, 2003	
	TATEMEN'			First Named Inventor	Robert H. Leung, Chiang	
	.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			Art Unit	3744	
	(Use as many	sheets as ne	ecessary)	Examiner Name	M. M. Ali	
Sheet	1	of	1	Attorney Docket Number	210_875RCE	

			U.S. PA	TENT DOCUMENTS	
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY 05-14-1940	Name of Patentee ² or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
me	AA*	US-2,200,502		G.G. Johnson	
/\ AB* US-2,384,313			P.R.M.M. Kohler		
		US-2,715,321	08-16-1955	R.J. Burger	
 		US-2,912,834	11-17-1959	L.J. Mann	
		US-2,986,901	06-06-1961	E.F. Hubacker	
		US-2,991,048		C. Rabin	
		US-3,012,760	12-12-1961	W.L. McGrath	
	AH*	US-3,267,692	08-23-1966	A.J. Pfeiffer et al.	
	AI*	US-3,577,744	05-04-1971	J. F. Mercer	
	AJ*	US-3,681,896	08-08-1972	Velkoff	
 	AK*	US-3,800,551	04-02-1974		
h	AL*	US-4,272,969	06-16-1981	Schwitzgebel et al.	
	AM*	US-4,434,843	03-06-1984		
	AN*	US-4,569,390	02-11-1986	Knowiton et al.	
	AO*	US-4,644,758	02-24-1987	Maehara et al.	
	AP*	US-5,179,845	01-19-1993	Sasaki et al.	
	AQ*	US-5,682,944	11-04-1997	Yamamoto et al.	
	AR*	US-5,743,098	04-28-1998	Behr	
—	AS*	US-5,755,108	05-26-1998	Ibrahim et al.	
	AT*	US-5,799,728	09-01-1998	Blume	
		US-5,832,995	11-10-1998	Chiang et al.	
	AV*	US-5,974,818	11-02-1999	Topper et al.	
		US-6,076,368	06-20-2000	Noble	
	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		08-15-2000	Dunne	
	AY*	US-6,167,619	01-02-2001	Beagle	
	AZ*	US-6,237,350	05-29-2001	Hertel et al.	
	AA1*	US-6,308,527	10-30-2001	Kuroyanagi et al.	
W	AB1*	US-6,679,080-A1	01-20-2004	Chiang et al.	
MA	AC1	US-6,923,013-A1	08-02-2005	Chiang et al.	

			FOREIG	SN PATENT	DOCUMENTS		
Examiner Initials*		Cite	Foreign Patent Document	Publication Date MM-OD-YYYY	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	١_
		No.	Country Code ³ -Number ⁴ -Kind Code ⁶ (# known)		Applicant of Cited Document		٣
M	A	BA	EU-1316119	06-04-2003	Ray Eshragui		
Ĭ.	_		JP-7189684	07-28-1995	Yuichi Sakamoto et al.		L
-4	Ì	BC	JP-8303933	11-22-1996	Izumi Azuma et al.		L
1	_		JP-10148441	06-02-1998	Tetsuya Inoue		L
M	لم	BE	JP-410185413	07-14-1998	Satoshi Kaneko		L.

*EXAMINER: initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. *CITE:NO.: Those application(s) which are marked with an single asterisk (*) next to the Cita No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. 'Applicant's unique citation designation number (optional). *See Kinds Codes of USPTO Patent Documents at \(\frac{\pi_1}{\pi_2} \frac{\pi_2}{\pi_3} \frac{\pi_3}{\pi_4} \frac{\pi_4}{\pi_4} \frac{\pi_4}{\

		<u> </u>		
Examiner Signature	/ (d . M.)	hein Ali	Date Considered	08-30-06